

FIG. 1A prior art

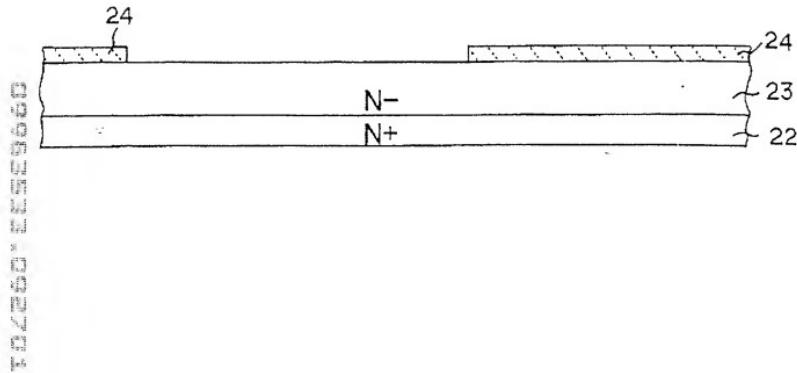


FIG. 1B prior art

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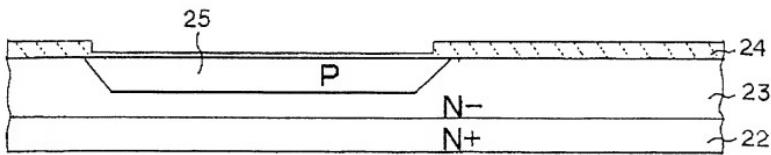


FIG. 1C prior art

T007270-20050906000

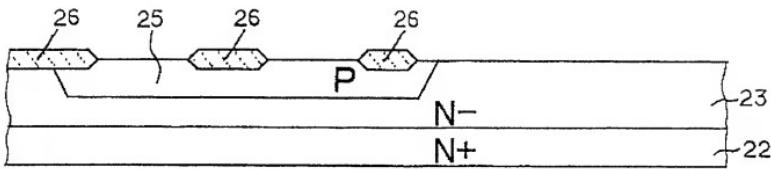


FIG. 1D prior art

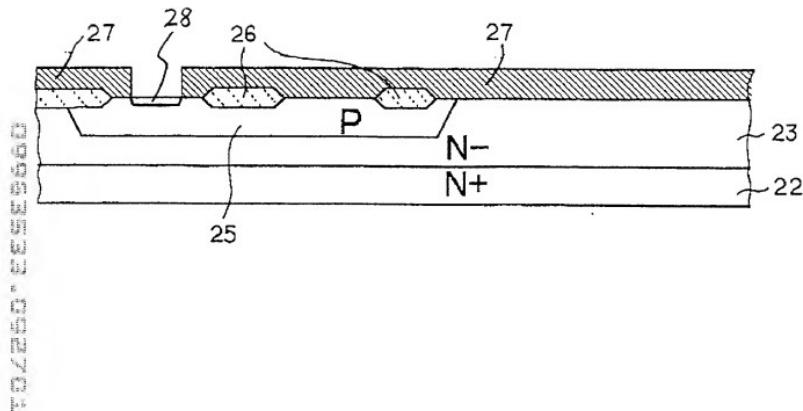


FIG. 1E prior art

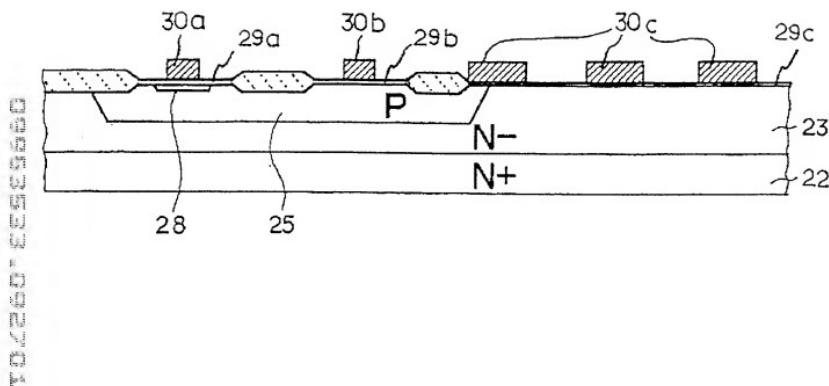


FIG. 1F prior art

DO NOT SCALE - DO NOT DRAW

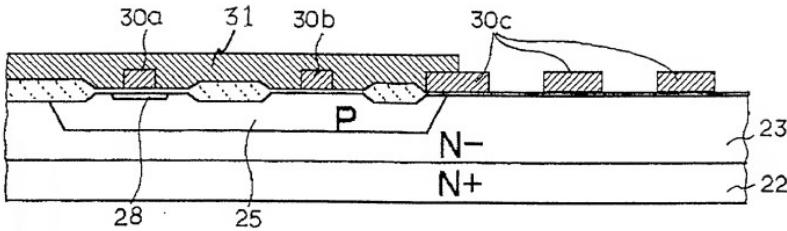


FIG. 1G prior art

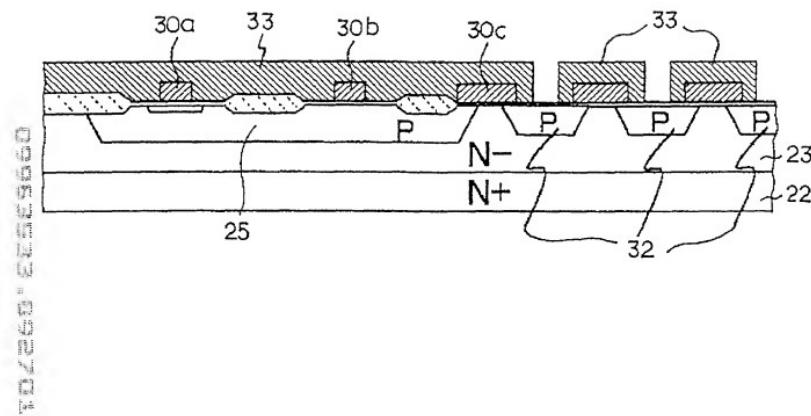


FIG. 1H prior art

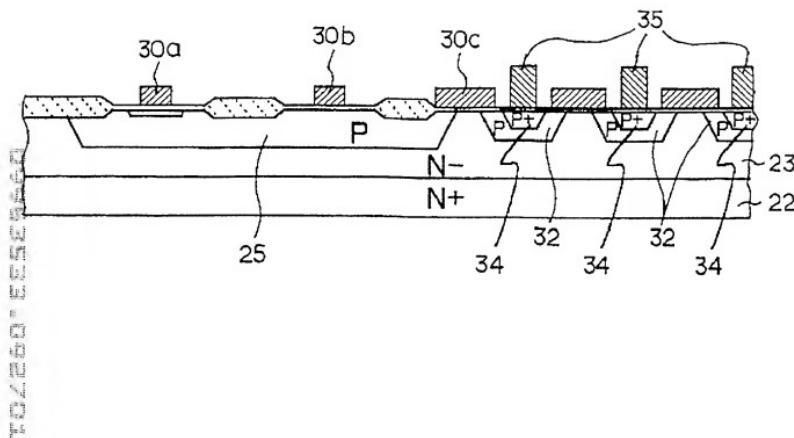
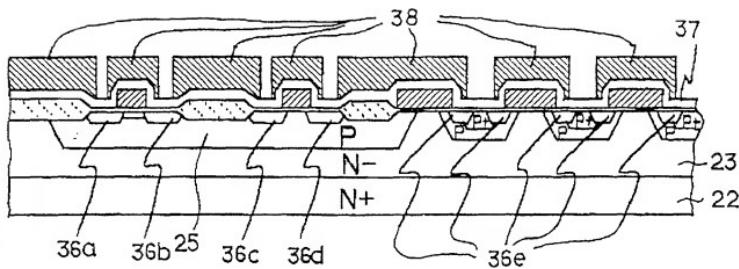


FIG. 1I prior art



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FIG. 1J prior art

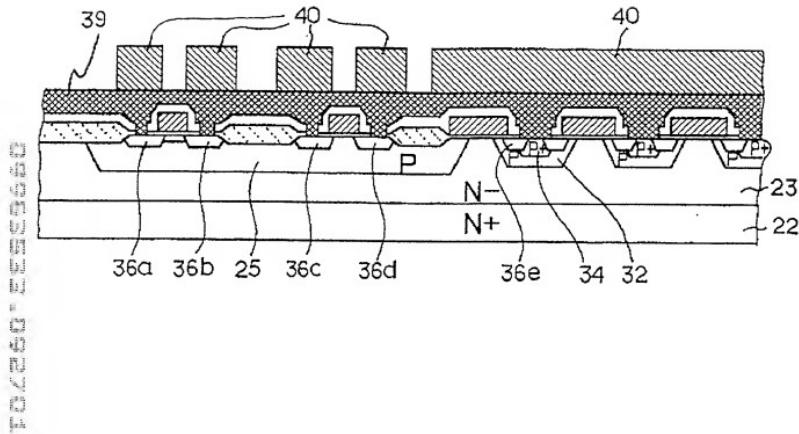


FIG. 1K prior art

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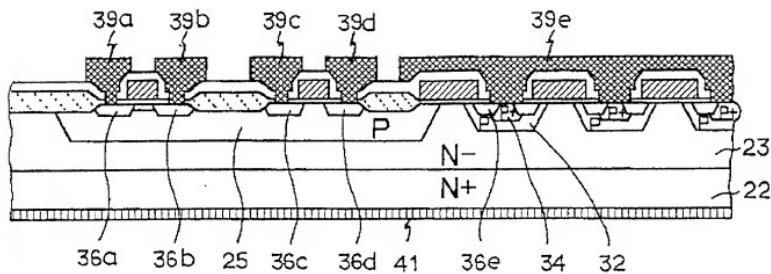


FIG. 2A

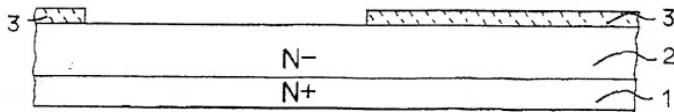
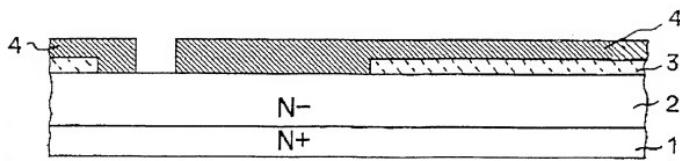
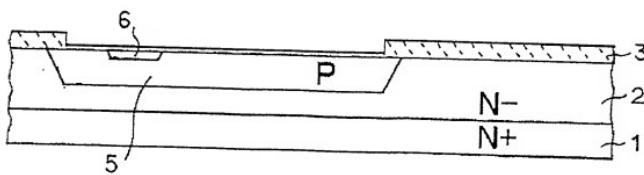


FIG. 2B



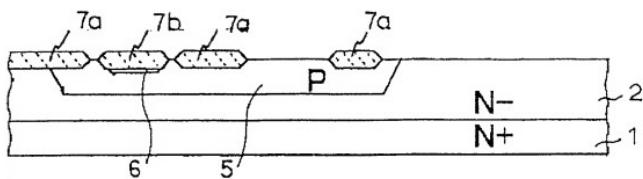
1012620 1012620 1012620

FIG. 2C



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FIG. 2D



TOP SECRET//EYES ONLY

FIG. 2E

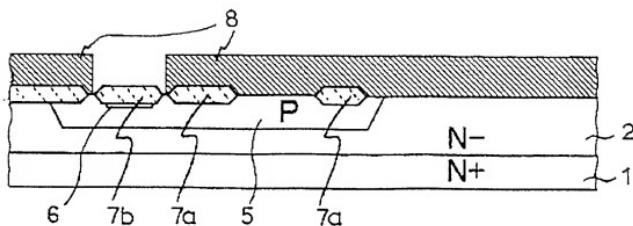
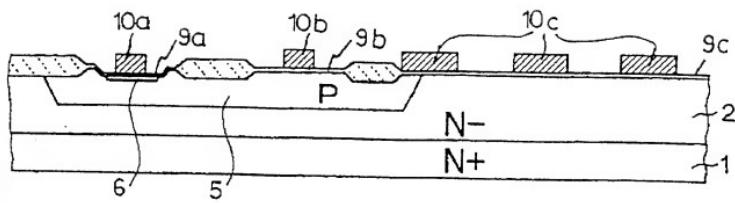
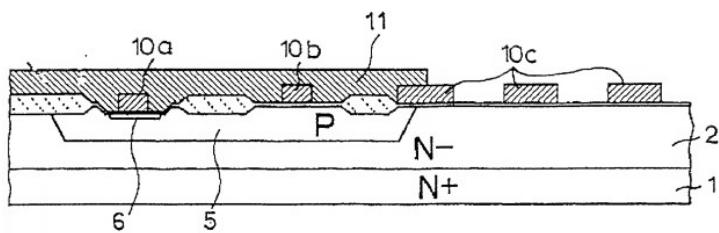


FIG. 2F



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FIG. 2G



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FIG. 2H

TOP VIEW FIGURE 2H

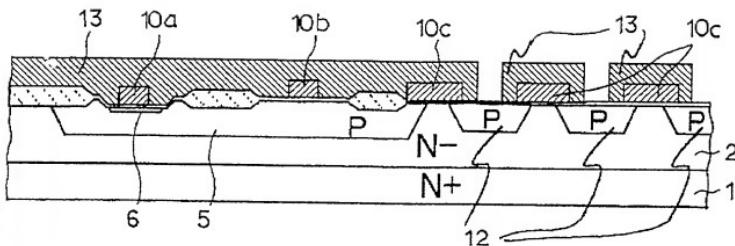


FIG. 2I

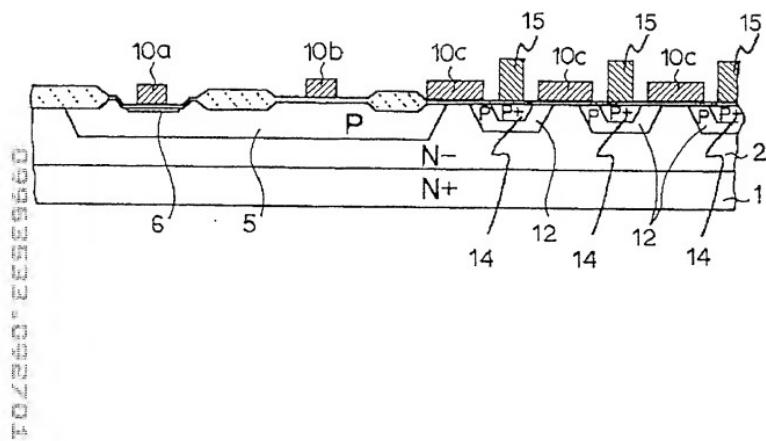
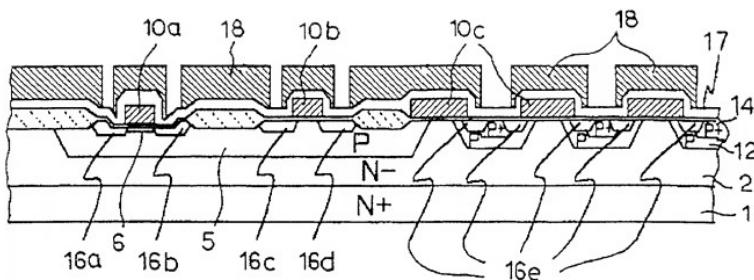


FIG. 2J



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FIG. 2K

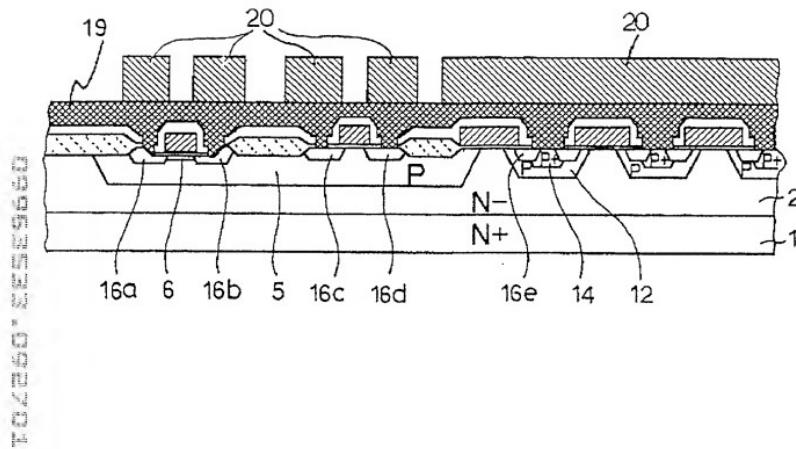


FIG. 2L

TOP VIEW - SECTION A-A

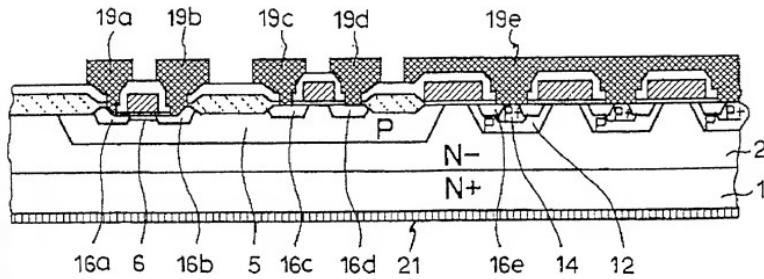


FIG. 3

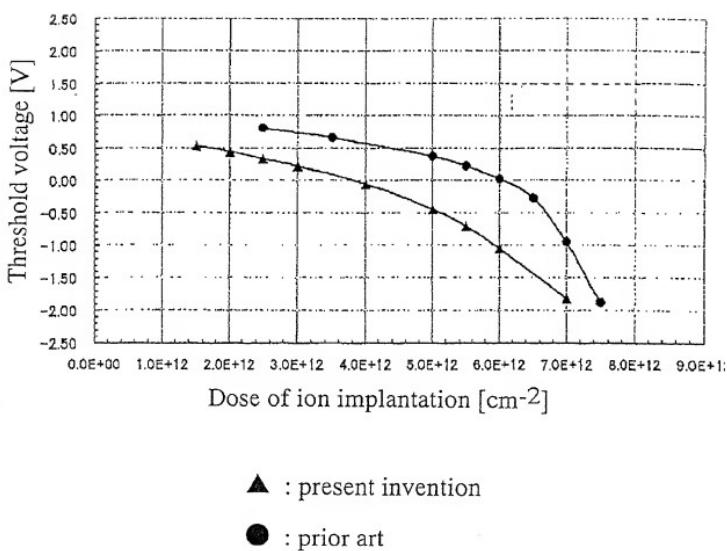
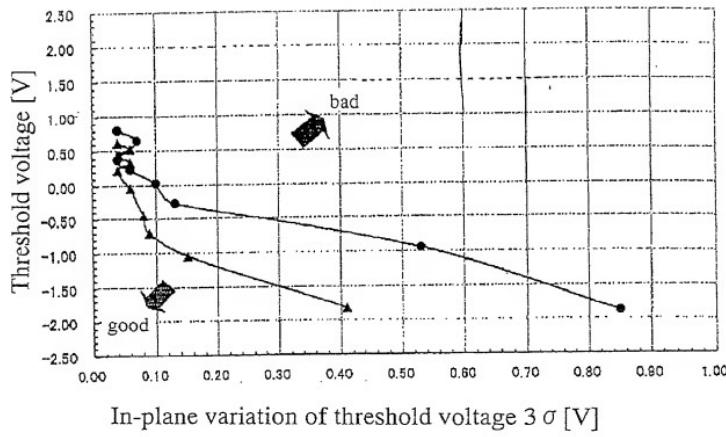


FIG. 4

In-plane variation of threshold voltage  $3\sigma$  [V]

▲ : present invention

● : prior art